


<b>Search Notes</b>  	<b>Application/Control No.</b>  10706515	<b>Applicant(s)/Patent Under Reexamination</b>  LUO ET AL.
	<b>Examiner</b>  Zhen, Li B	<b>Art Unit</b>  2194

### SEARCHED

Class	Subclass	Date	Examiner
719	315,316,328,330	2/19/2007	LZ
717	108	2/19/2007	LZ
Update	Search	7/30/2007	LZ

### SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	2/19/2007	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	7/30/2007	LZ

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner